BLM7G1822S-20PB; BLM7G1822S-20PBG

LDMOS 2-stage power MMIC

Rev. 3 — 1 July 2015

Product data sheet

1. Product profile

1.1 General description

The BLM7G1822S-20PB(G) is a dual section, 2-stage power MMIC using NXP's state of the art GEN7 LDMOS technology. This multiband device is perfectly suited as general purpose driver or small cell final in the frequency range from 1805 MHz to 2170 MHz. Available in gull wing or straight lead outline.

Table 1. Performance

Typical RF performance at $T_{case} = 25$ °C; $I_{Dq1} = 27$ mA; $I_{Dq2} = 76$ mA. Test signal: 3GPP test model 1; 64 DPCH; PAR = 9.9 dB at 0.01% probability on CCDF; per section unless otherwise specified in a class-AB production circuit.

| Test signal | f | V _{DS} | P _{L(AV)} | G _p | η_D | ACPR _{5M} |
|-----------------------|--------|-----------------|--------------------|----------------|----------|--------------------|
| | (MHz) | (V) | (W) | (dB) | (%) | (dBc) |
| single carrier W-CDMA | 2167.5 | 28 | 2 | 32.3 | 23 | -41 |

1.2 Features and benefits

- Designed for broadband operation (frequency 1805 MHz to 2170 MHz)
- High section-to-section isolation enabling multiple combinations
- Integrated temperature compensated bias
- Biasing of individual stages is externally accessible
- Integrated ESD protection
- Excellent thermal stability
- High power gain
- On-chip matching for ease of use
- Compliant to Directive 2002/95/EC, regarding restriction of hazardous substances (RoHS)

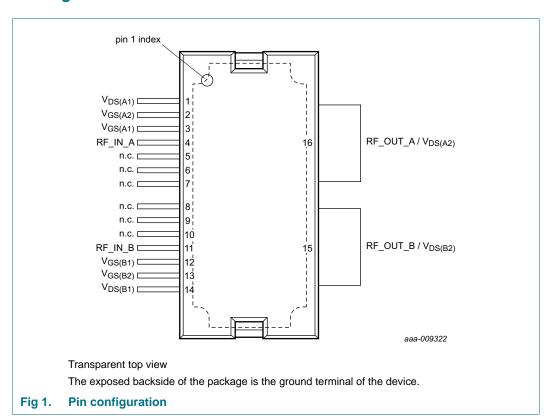
1.3 Applications

- RF power MMIC for multi-carrier and multi-standard GSM, W-CDMA and LTE base stations in the 1805 MHz to 2170 MHz frequency range. Possible circuit topologies are the following as also depicted in Section 8.1:
 - Dual section or single ended
 - Doherty
 - Quadrature combined
 - Push-pull



2. Pinning information

2.1 Pinning



2.2 Pin description

Table 2. Pin description

| Symbol | Pin | Description |
|---------------------|-----|---|
| V _{DS(A1)} | 1 | drain-source voltage of driver stage A1 |
| V _{GS(A2)} | 2 | gate-source voltage of final stage A2 |
| V _{GS(A1)} | 3 | gate-source voltage of driver stage A1 |
| RF_IN_A | 4 | RF input section A |
| n.c. | 5 | not connected |
| n.c. | 6 | not connected |
| n.c. | 7 | not connected |
| n.c. | 8 | not connected |
| n.c. | 9 | not connected |
| n.c. | 10 | not connected |
| RF_IN_B | 11 | RF input section B |
| V _{GS(B1)} | 12 | gate-source voltage of driver stage B1 |
| V _{GS(B2)} | 13 | gate-source voltage of final stage B2 |
| V _{DS(B1)} | 14 | drain-source voltage of driver stage B1 |

 Table 2.
 Pin description ...continued

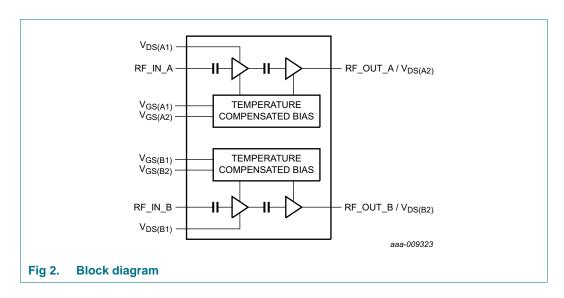
| Symbol | Pin | Description |
|------------------------------|--------|--|
| RF_OUT_B/V _{DS(B2)} | 15 | RF output section B / drain-source voltage of final stage B2 |
| RF_OUT_A/V _{DS(A2)} | 16 | RF output section A / drain-source voltage of final stage A2 |
| GND | flange | RF ground |

3. Ordering information

Table 3. Ordering information

| Type number | Package | | | | | | |
|------------------|---------|---|-----------|--|--|--|--|
| | Name | Description | Version | | | | |
| BLM7G1822S-20PB | HSOP16F | plastic, heatsink small outline package; 16 leads(flat) | SOT1211-2 | | | | |
| BLM7G1822S-20PBG | HSOP16 | plastic, heatsink small outline package; 16 leads | SOT1212-2 | | | | |

4. Block diagram



5. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

| Symbol | Parameter | Conditions | Min | Max | Unit |
|-------------------|----------------------|------------|------|------|------|
| V_{DS} | drain-source voltage | | - | 65 | V |
| V_{GS} | gate-source voltage | | -0.5 | +13 | V |
| T _{stg} | storage temperature | | -65 | +150 | °C |
| Tj | junction temperature | [1] | - | 225 | °C |
| T _{case} | case temperature | | - | 150 | °C |

^[1] Continuous use at maximum temperature will affect the reliability. For details refer to the online MTF calculator.

6. Thermal characteristics

Table 5. Thermal characteristics

Measured for total device.

| Symbol | Parameter | Conditions | Value | Unit |
|----------------------|--|---|-------|------|
| R _{th(j-c)} | thermal resistance from junction to case | final stage; $T_{case} = 90 ^{\circ}\text{C}$; $P_L = 3.56 \text{W}$ | 1.9 | K/W |
| | | driver stage; $T_{case} = 90 ^{\circ}C$; $P_{L} = 3.56 W$ | 6.2 | K/W |

^[1] When operated with a CW signal.

7. Characteristics

Table 6. DC characteristics

 T_{case} = 25 °C; per section unless otherwise specified.

| Symbol | Parameter | Conditions | | Min | Тур | Max | Unit |
|--------------------------|--|---|------------|-----|------|-----|------|
| Final stag | je | | | | | | |
| V _{(BR)DSS} | drain-source breakdown voltage | $V_{GS} = 0 \text{ V}; I_D = 150.8 \ \mu\text{A}$ | | 65 | - | - | V |
| V_{GSq} | gate-source quiescent voltage | $V_{DS} = 28 \text{ V}; I_D = 76 \text{ mA}$ | | 1.5 | 2 | 2.5 | V |
| | | $V_{DS} = 28 \text{ V}; I_D = 76 \text{ mA}$ | <u>[1]</u> | 1.7 | 2.65 | 3.6 | V |
| $\Delta I_{Dq}/\Delta T$ | quiescent drain current variation with temperature | -40 °C ≤ T _{case} ≤ +85 °C | <u>[1]</u> | - | ±1 | - | % |
| I _{DSS} | drain leakage current | V _{GS} = 0 V; V _{DS} = 28 V | | - | - | 1.4 | μΑ |
| I _{DSX} | drain cut-off current | $V_{GS} = 5.55 \text{ V}; V_{DS} = 10 \text{ V}$ | | - | 2.8 | - | Α |
| I _{GSS} | gate leakage current | V _{GS} = 1.0 V; V _{DS} = 0 V | | - | - | 140 | nA |
| Driver sta | ge | | | | | | |
| V _{(BR)DSS} | drain-source breakdown voltage | $V_{GS} = 0 \text{ V}; I_D = 30.16 \mu\text{A}$ | | 65 | - | - | V |
| V_{GSq} | gate-source quiescent voltage | $V_{DS} = 28 \text{ V}; I_D = 27 \text{ mA}$ | | 1.6 | 2.1 | 2.6 | V |
| | | $V_{DS} = 28 \text{ V}; I_D = 27 \text{ mA}$ | [2] | 1.9 | 2.85 | 3.8 | V |
| $\Delta I_{Dq}/\Delta T$ | quiescent drain current variation with temperature | -40 °C ≤ T _{case} ≤ +85 °C | [2] | - | ±1 | - | % |
| I _{DSS} | drain leakage current | V _{GS} = 0 V; V _{DS} = 28 V | | - | - | 1.4 | μΑ |
| I _{DSX} | drain cut-off current | $V_{GS} = 5.55 \text{ V}; V_{DS} = 10 \text{ V}$ | | - | 0.55 | - | Α |
| I _{GSS} | gate leakage current | V _{GS} = 1.0 V; V _{DS} = 0 V | | - | - | 140 | nA |

^[1] In production circuit with 1105 Ω gate feed resistor.

^[2] In production circuit with 765 Ω gate feed resistor.

Table 7. RF Characteristics

Typical RF performance at $T_{case} = 25$ °C; $V_{DS} = 28$ V; $I_{Dq1} = 27$ mA; $I_{Dq2} = 76$ mA; $P_{L(AV)} = 2$ W. Per section unless otherwise specified, measured in a NXP wideband f = 1807.5 MHz to 2167.5 MHz straight lead production circuit.

| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|----------------------|--|--|------|------|------|------|
| Test signa | ıl: single carrier W-CDMA [1] | | | | | |
| Gp | power gain | f = 1807.5 MHz | - | 34 | - | dB |
| | | f = 2167.5 MHz | 30.8 | 32.3 | 33.8 | dB |
| η _D | drain efficiency | f = 1807.5 MHz | - | 22 | - | % |
| | | f = 2167.5 MHz | 20 | 23 | - | % |
| RLin | input return loss | f = 2167.5 MHz | - | -19 | -10 | dB |
| ACPR _{5M} | adjacent channel power ratio (5 MHz) | f = 1807.5 MHz | - | -41 | - | dBc |
| | | f = 2167.5 MHz | - | -41 | -37 | dBc |
| PARO | output peak-to-average ratio | f = 1807.5 MHz | - | 8.4 | - | dB |
| | | f = 2167.5 MHz | 7.2 | 8.4 | - | dB |
| ΔI _{Dq} /ΔT | quiescent drain current variation with temperature | T = -40 °C to +85 °C | | | | |
| | | final stage I_{Dq} ; gate feed resistor = 1105 Ω | - | ±1 | - | % |
| | | driver stage I_{Dq} ; gate feed resistor = 765 Ω | - | ±1 | - | % |
| Test signa | ıl: CW [2] | + | - | + | 1 | |
| $\Delta \phi_{s21}$ | phase response difference | between sections | -10 | - | +10 | deg |
| $\Delta s_{21} ^2$ | insertion power gain difference | between sections | -0.5 | - | +0.5 | dB |

^{[1] 3}GPP test model 1; 64 DPCH; PAR = 9.9 dB at 0.01% probability on CCDF.

8. Application information

Table 8. Typical performance

Test signal: 1-tone CW; RF performance at $T_{\text{case}} = 25 \,^{\circ}\text{C}$; $V_{DS} = 28 \,^{\circ}\text{V}$; $I_{Dq1} = 45 \,^{\circ}\text{mA}$ (both sections); $I_{Dq2} = 140 \,^{\circ}\text{mA}$ (both sections) unless otherwise specified, measured in a NXP $f = 2110 \,^{\circ}\text{MHz}$ to 2170 MHz straight lead class AB application circuit (see Figure 3 for the component layout and Figure 4 for the electrical schematic).

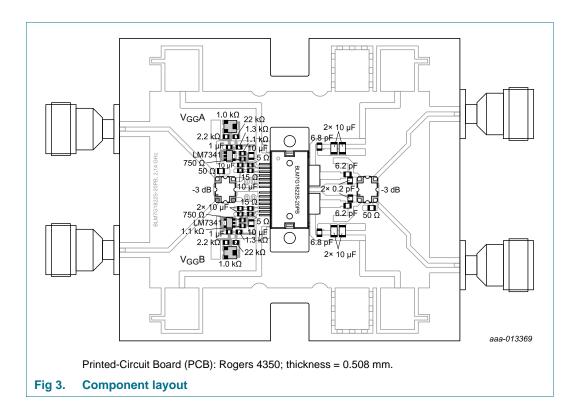
| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|--------------------------------|---------------------------------------|--|-----|------|-----|-------|
| P _{L(1dB)} | output power at 1 dB gain compression | f = 2140 MHz | - | 43.5 | - | W |
| P _{L(3dB)} | output power at 3 dB gain compression | f = 2140 MHz | - | 44.1 | - | W |
| η_{D} | drain efficiency | at P _{L(1dB)} ; f = 2140 MHz | - | 47.6 | - | % |
| Gp | power gain | P _{L(AV)} = 1.585 W; f = 2140 MHz | - | 31.5 | - | dB |
| B _{video} | video bandwidth | 2-tone CW; P _{L(AV)} = 1.585 W; f = 2140 MHz | - | 170 | - | MHz |
| G _{flat} | gain flatness | over a frequency range of 60 MHz; $P_{L(AV)} = 1.585 \text{ W}$ | - | 0.4 | - | dB |
| ΔG/ΔΤ | gain variation with temperature | f = 2140 MHz | - | 0.03 | - | dB/°C |
| S ₁₂ ² | isolation | between sections A and B; [1] $P_{L(AV)} = 1.585 \text{ W}$; f = 2140 MHz | - | 28.5 | - | dB |
| K | Rollett stability factor | T = -40 °C; $f = 0.1$ GHz to 3 GHz | - | >1 | - | |

^[1] Measured on dual section evaluation board I_{Dq1} = 40 mA (both sections); I_{Dq2} = 150 mA (both sections).

BLM7G1822S-20PB_S-20PBG

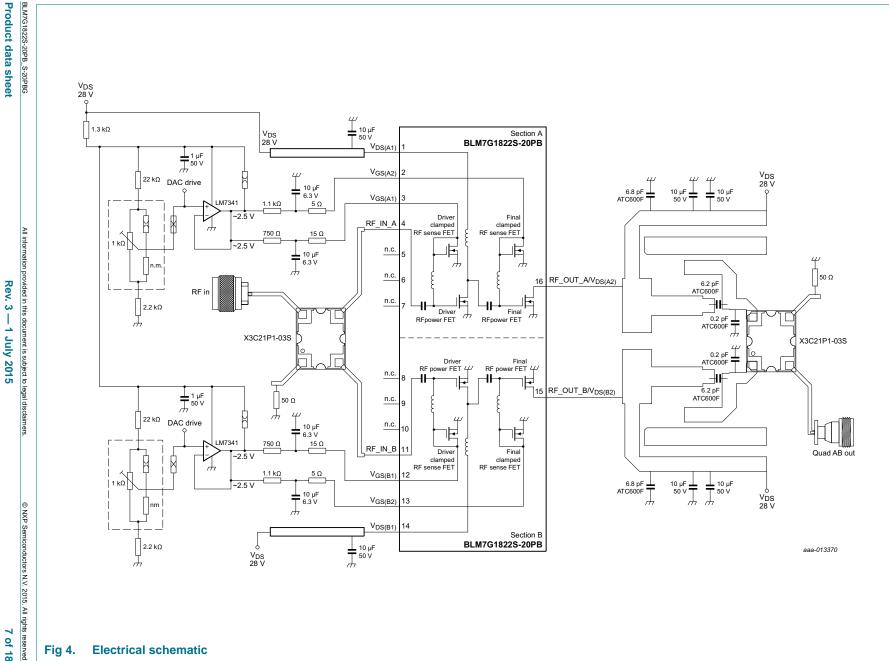
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^[2] f = 2170 MHz.

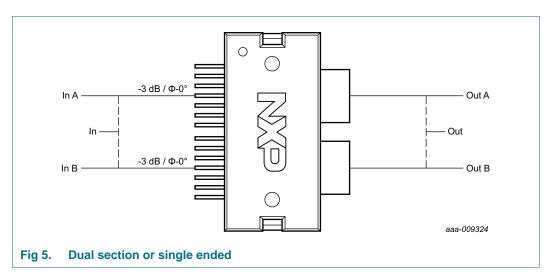


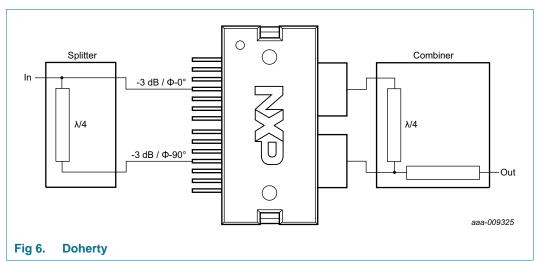
NXP Semiconductors

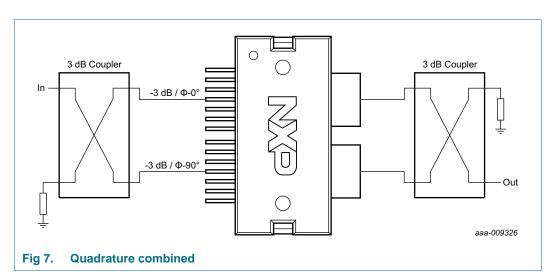
LDMOS 2-stage power MMIC

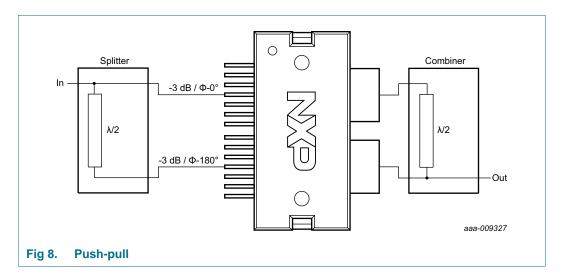


8.1 Possible circuit topologies









8.2 Ruggedness in class-AB operation

The BLM7G1822S-20PB and BLM7G1822S-20PBG are capable of withstanding a load mismatch corresponding to VSWR = 10 : 1 through all phases under the following conditions: $V_{DS} = 32 \text{ V}$; $I_{Dq1} = 20 \text{ mA}$ (per section); $I_{Dq2} = 75 \text{ mA}$ (per section); $P_i = 16 \text{ dBm}$ (CW and corresponding to $P_{L(3dB)}$ under $Z_S = 50 \Omega$ load); f = 2140 MHz.

8.3 Impedance information

Table 9. Typical impedance at 3 dB compression point

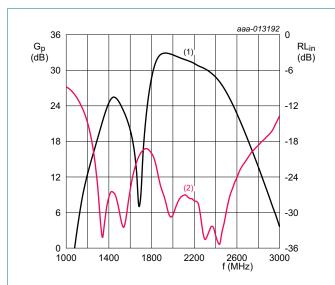
Measured load-pull data per section; test signal: pulsed CW; $T_{\rm case}$ = 25 °C; $V_{\rm DS}$ = 28 V; $I_{\rm Dq1}$ = 20 mA; $I_{\rm Dq2}$ = 65 mA; $I_{\rm pq}$ = 100 μ s; δ = 10 %; $Z_{\rm S}$ = 50 Ω . Typical values unless otherwise specified.

| tuned for maximum output power | | | | | tuned for maximum efficiency | | | | | |
|--------------------------------|----------------|---------------------|------|------------------|------------------------------|----------------|---------------------|------|------------------|------------------|
| f | Z _L | G _{p(max)} | PL | η _{add} | AM-PM conversion | Z _L | G _{p(max)} | PL | η _{add} | AM-PM conversion |
| (MHz) | (Ω) | (dB) | (W) | (%) | (deg) | (Ω) | (dB) | (W) | (%) | (deg) |
| BLM7G1 | 822S-20PB | | | | | | | | | |
| 1700 | 15.3 – j14.5 | 33.2 | 42.7 | 50.6 | 8.3 | 28.5 – j20.2 | 34.6 | 41.6 | 56.5 | 9.2 |
| 1800 | 16.3 – j11.7 | 32.9 | 42.7 | 50.8 | 6.3 | 31.3 – j8.60 | 34.1 | 41.6 | 57.1 | 7.0 |
| 1900 | 16.1 – j9.70 | 32.1 | 42.8 | 50.8 | 6.1 | 26.5 – j0.01 | 33.3 | 41.7 | 57.3 | 6.9 |
| 2000 | 15.5 – j8.10 | 31.5 | 42.8 | 50.1 | 6.1 | 21.0 + j2.20 | 32.6 | 42.0 | 56.4 | 7.3 |
| 2100 | 14.4 – j6.90 | 31.5 | 42.9 | 50.0 | 6.9 | 15.6 + j2.00 | 32.9 | 42.1 | 55.8 | 8.6 |
| 2200 | 13.7 – j6.60 | 31.7 | 42.7 | 49.8 | 8.5 | 12.3 + j1.20 | 33.0 | 41.6 | 54.3 | 9.6 |
| 2300 | 12.8 – j6.80 | 31.4 | 42.5 | 49.1 | 10.6 | 10.0 + j0.10 | 32.5 | 41.3 | 53.6 | 10.3 |
| BLM7G1 | 822S-20PBG | | | | | | | | | |
| 1700 | 15.8 – j16.1 | 33.5 | 42.5 | 52.9 | 9.2 | 28.9 – j21.8 | 35.1 | 41.6 | 57.9 | 11.1 |
| 1800 | 16.5 – j13.8 | 32.9 | 42.5 | 51.2 | 7.7 | 30.6 – j11.6 | 34.2 | 41.6 | 56.8 | 8.4 |
| 1900 | 16.7 – j12.4 | 32.2 | 42.5 | 50.2 | 7.2 | 27.9 – j4.64 | 33.5 | 41.7 | 55.9 | 7.8 |
| 2000 | 16.3 – j9.74 | 31.7 | 42.5 | 51.2 | 7.3 | 20.4 + j0.45 | 32.7 | 41.7 | 55.6 | 9.0 |
| 2100 | 15.6 – j8.61 | 31.5 | 42.6 | 52.0 | 9.5 | 15.9 + j0.68 | 32.6 | 41.7 | 56.5 | 11.8 |
| 2200 | 14.6 – j8.87 | 31.3 | 42.5 | 49.7 | 10.3 | 12.7 – j0.44 | 32.4 | 41.6 | 53.8 | 12.1 |
| 2300 | 13.4 – j9.32 | 30.5 | 42.4 | 48.2 | 12.8 | 10.7 – j1.98 | 31.7 | 41.6 | 53.7 | 13.2 |

BLM7G1822S-20PB_S-20PBG

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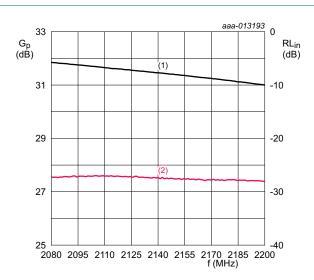
8.4 Graphs



 T_{case} = 25 °C; V_{DS} = 28 V; I_{Dq1} = 22 mA; I_{Dq2} = 70 mA; P_L = 1.585 W. Per section.

- (1) magnitude of Gp
- (2) magnitude of RLin

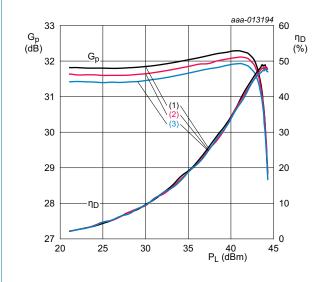
Fig 9. Wideband power gain and input return loss as function of frequency; typical values



 T_{case} = 25 °C; V_{DS} = 28 V; I_{Dq1} = 22 mA; I_{Dq2} = 70 mA; P_L = 1.585 W. Per section.

- (1) magnitude of G_p
- (2) magnitude of RLin

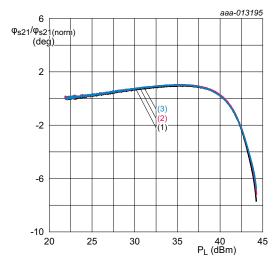
Fig 10. In-band power gain and input return loss as function of frequency; typical values



 T_{case} = 25 °C; V_{DS} = 28 V; I_{Dq1} = 22 mA; I_{Dq2} = 70 mA. Per section.

- (1) f = 2110 MHz
- (2) f = 2140 MHz
- (3) f = 2170 MHz

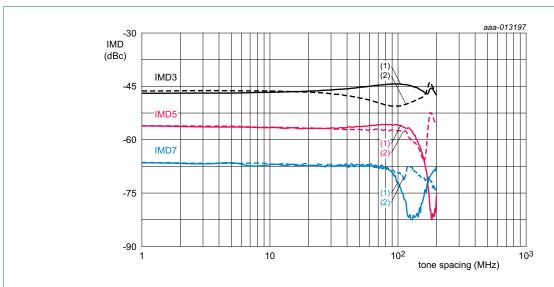
Fig 11. Power gain and drain efficiency as function of output power; typical values



Normalized at P_L = 22 dBm; T_{case} = 25 °C; V_{DS} = 28 V; I_{Dq1} = 22 mA; I_{Dq2} = 70 mA. Per section.

- (1) f = 2110 MHz
- (2) f = 2140 MHz
- (3) f = 2170 MHz

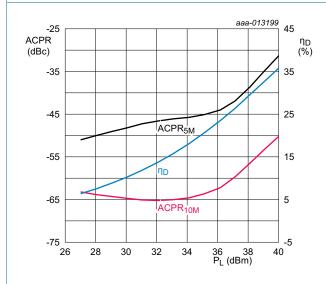
Fig 12. Normalized phase response as a function of output power; typical values



 $T_{case} = 25 \, ^{\circ}\text{C}; \, V_{DS} = 28 \, \text{V}; \, I_{Dq1} = 22 \, \text{mA}; \, I_{Dq2} = 70 \, \text{mA}; \, f = 2140 \, \text{MHz}; \, 2\text{-tone CW}; \, P_{L(AV)} = 0.25 \, \text{W}. \, \text{Per section}.$

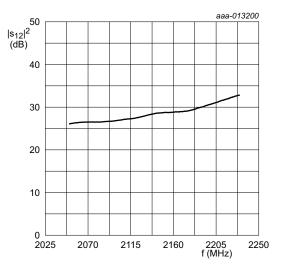
- (1) IMD low
- (2) IMD high

Fig 13. Intermodulation distortion as a function of tone spacing; typical values



 $T_{case}=25~^{\circ}C;~V_{DS}=28~V;~I_{Dq1}=22~mA;~I_{Dq2}=70~mA;~f=2140~MHz;~1-carrier~W-CDMA;~test~model~1;~PAR=7.2~dB~at~0.01~\%~probability~on~CCDF.~Per~section.$





 $T_{case} = 25~^{\circ}C; V_{DS} = 28~V; I_{Dq1} = 20~mA; I_{Dq2} = 75~mA.$ Per section. Measured on evaluation board.

Fig 15. Isolation as a function of frequency; typical values

9. Package outline

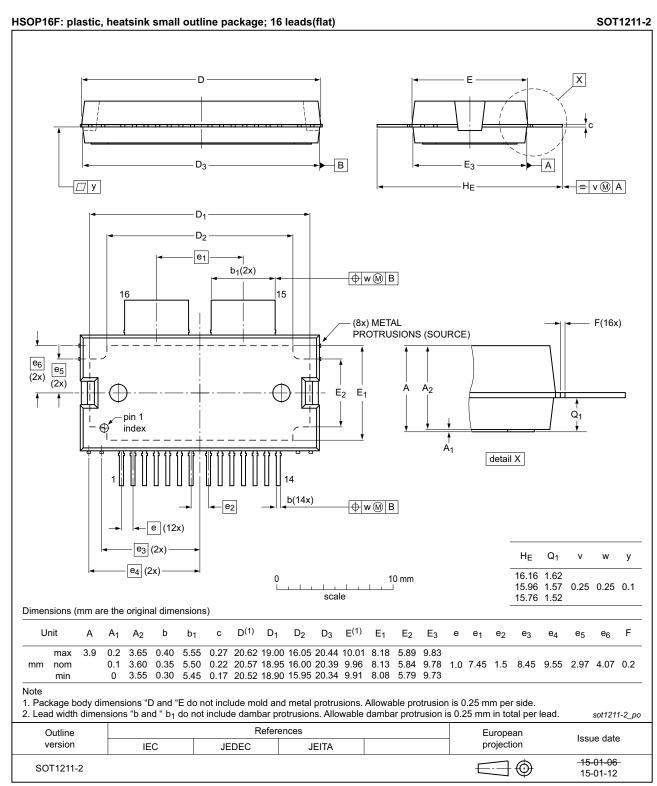


Fig 16. Package outline SOT1211-2 (HSOP16F)

BLM7G1822S-20PB_S-20PBG

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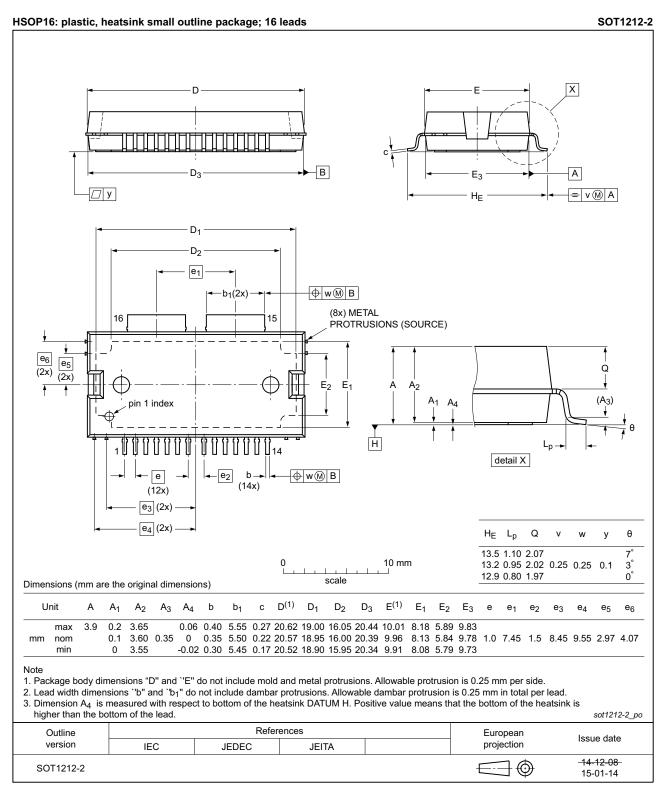


Fig 17. Package outline SOT1212-2 (HSOP16)

BLM7G1822S-20PB_S-20PBG

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10. Handling information

CAUTION



This device is sensitive to ElectroStatic Discharge (ESD). Observe precautions for handling electrostatic sensitive devices.

Such precautions are described in the ANSI/ESD S20.20, IEC/ST 61340-5, JESD625-A or equivalent standards.

11. Abbreviations

Table 10. Abbreviations

| Acronym | Description |
|---------|--|
| AM | Amplitude Modulation |
| 3GPP | 3rd Generation Partnership Project |
| CCDF | Complementary Cumulative Distribution Function |
| CW | Continuous Wave |
| DPCH | Dedicated Physical CHannel |
| ESD | ElectroStatic Discharge |
| GEN7 | Seventh Generation |
| GSM | Global System for Mobile Communications |
| LDMOS | Laterally Diffused Metal Oxide Semiconductor |
| LTE | Long Term Evolution |
| MMIC | Monolithic Microwave Integrated Circuit |
| MTF | Median Time to Failure |
| PAR | Peak-to-Average Ratio |
| PM | Phase Modulation |
| VSWR | Voltage Standing-Wave Ratio |
| W-CDMA | Wideband Code Division Multiple Access |

12. Revision history

Table 11. Revision history

| Document ID | Release date | Data sheet status | Change notice | Supersedes |
|-----------------------------|---------------|--|--------------------|---------------------------------|
| BLM7G1822S-20PB_S-20PBG v.3 | 20150701 | Product data sheet | - | BLM7G1822S-20PB_ S-20PBG v.2 |
| Modifications: | Table 1 on | page 1: the table has been | n updated | |
| | Section 1.3 | on page 1: first paragrapl | h has been update | d |
| | • Table 2 on | page 2: the table has been | n updated | |
| | | page 3: the package versi SOT1211-2 | on of the BLM7G1 | 822S-20PB has been |
| | | page 3: the package versi SOT1212-2 | on of the BLM7G1 | 822S-20PBG has been |
| | • Table 6 on | page 4: the table has been | n updated | |
| | • Table 7 on | page 5: the table has been | n updated | |
| | • Table 8 on | page 5: the general condit | tions have been up | odated |
| | • Figure 3 or | n page 6: the title of the fig | ure has been chan | iged |
| | Section 8.2 | on page 9: the section ha | as been updated | |
| | • Table 9 on | page 9: the table has been | n updated | |
| | • Figure 16 c | on page 12: the figure now | shows the SOT12 | 211-2 package outline |
| | • Figure 17 c | on page 13: the figure now | shows the SOT12 | 212-2 package outline |
| BLM7G1822S-20PB_S-20PBG v.2 | 20140626 | Objective data sheet | - | BLM7G1822S-20PB_ S-20PBG v.1 |
| BLM7G1822S-20PB_S-20PBG v.1 | 20131219 | Objective data sheet | - | - |

13. Legal information

13.1 Data sheet status

| Document status[1][2] | Product status[3] | Definition |
|--------------------------------|-------------------|---|
| Objective [short] data sheet | Development | This document contains data from the objective specification for product development. |
| Preliminary [short] data sheet | Qualification | This document contains data from the preliminary specification. |
| Product [short] data sheet | Production | This document contains the product specification. |

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions"
- [3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL http://www.nxp.com.

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